Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,092	KARR ET AL.	
Examiner	**Art Unit**	
Duc M. Nguyen	2685	

SEARCHED			
Class	Subclass	Date	Examiner
455	550 552.1 553.1		
	41.1 41.2		
	41.3 102		
	108 110		
	561 7		
	11.1 17 23		
370	315		
	319->321		
714	746		
	786 798		
340	7.28->		
	->7.51		
375	219		
	220 223	3/1/06	SDV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR